

# N-Channel Enhancement Mode Field Effect Transistor with Schottky Diode

#### **General Description**

The AO4704 uses advanced trench technology to provide excellent  $R_{\text{DS(ON)}}$ , shoot-through immunity and body diode characteristics. This device is suitable for use as a synchronous switch in PWM applications. The co-packaged Schottky Diode boosts efficiency further.

#### **Features**

 $V_{DS}(V) = 30V$ 

 $I_D = 12 \text{ A } (V_{GS} = 10 \text{V})$ 

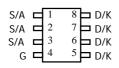
 $R_{DS(ON)} < 11.5 m\Omega (V_{GS} = 10V)$ 

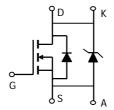
 $R_{DS(ON)}$  < 13m $\Omega$  ( $V_{GS}$  = 4.5V)

#### **SCHOTTKY**

VDS (V) = 30V, IF = 3A, VF<0.5V@1A

#### SOIC-8





Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted									
Parameter		Symbol	MOSFET	Schottky	Units				
Drain-Source Voltage		$V_{DS}$	30		V				
Gate-Source Voltage		$V_{GS}$	±12		V				
	T <sub>A</sub> =25°C	_	12						
Continuous Drain Current <sup>A</sup>	T <sub>A</sub> =70°C	- I <sub>D</sub>	10.4		Α				
Pulsed Drain Current <sup>B</sup>		I <sub>DM</sub>	40						
Schottky reverse voltage		$V_{KA}$		30	V				
	T <sub>A</sub> =25°C	- I <sub>F</sub>		4.4					
Continuous Forward Current <sup>A</sup>	T <sub>A</sub> =70°C	] 'F		3.2	Α				
Pulsed Diode Forward Current <sup>B</sup>		I <sub>FM</sub>		30					
	T <sub>A</sub> =25°C	P <sub>D</sub>	3.1	3.1	W				
Power Dissipation	T <sub>A</sub> =70°C	' D	2	2	\ \ \ \ \ \				
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	-55 to 150	°C				



Thermal Characteristics						
Parameter		Symbol	ol Typ Max		Units	
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	$R_{\theta JA}$	28	40	°C/W	
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State	R <sub>θ</sub> JA	54	75	°C/W	
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	21	30	°C/W	

Thermal Characteristics: Schottky						
Parameter		Symbol	Typ Max		Units	
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	$R_{\theta JA}$	36	40	°C/W	
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State	N <sub>θ</sub> JA	67	75	°C/W	
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	25	30	°C/W	

A: The value of  $R_{BJA}$  is measured with the device mounted on 1in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $\leq$  10s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

- C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.
- D. The static characteristics in Figures 1 to 6 are obtained using 80  $\,\mu s$  pulses, duty cycle 0.5% max.
- E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The SOA curve provides a single pulse rating.

  F. The Schottky appears in parallel with the MOSFET body diode, even though it is a separate chip. Therefore, we provide the net forward drop,
- F. The Schottky appears in parallel with the MOSFET body diode, even though it is a separate chip. Therefore, we provide the net forward drop capacitance and recovery characteristics of the MOSFET and Schottky. However, the thermal resistance is specified for each chip separately.



#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V
	Zana Oata Valta na Busin Oamant	V <sub>R</sub> =30V			0.007		
Zero Gate Voltage Drain Currel   (Set by Schottky leakage)	Zero Gate Voltage Drain Current.	V <sub>R</sub> =30V, T <sub>J</sub> =125°C			3.2		mA
	Set by Schottky leakage)	V <sub>R</sub> =30V, T <sub>J</sub> =150°C		12			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±12V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250 \mu A$		0.5		2.0	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> =4.5V, V <sub>DS</sub> =5V		40			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, ID=13A			8.0		mO
			T <sub>J</sub> =125°C		11.0		mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =12.2A			9.0		mΩ
<b>9</b> FS	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =13A		30	37		S
$V_{SD}$	Diode + Schottky Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.45	0.5	V
Is	Maximum Body-Diode + Schottky Continuous Current					5	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance				3656		pF
Coss	Output Capacitance (FET+Schottky)	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			322		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				168		pF
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			0.86	1.1	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (4.5V)	Total Gate Charge				30.5	36	nC
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =13A			4.6		nC
$Q_{gd}$	Gate Drain Charge				8.6		nC
t <sub>D(on)</sub>	Turn-On DelayTime				6.2	9	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =1.1 $\Omega$ ,			4.8	7	ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}$ =0 $\Omega$			55	75	ns
t <sub>f</sub>	Turn-Off Fall Time	1			7.3	11	ns
t <sub>rr</sub>	Body Diode+Schottky Reverse Recovery Time	I <sub>F</sub> =13A, dI/dt=100A/μs			20.3	25	ns
Q <sub>rr</sub>	Body Diode+Schottky Reverse Recovery Charge	I <sub>F</sub> =13A, dI/dt=100A/μs			8.4	12.5	nC

A: The value of R<sub>0,JA</sub> is measured with the device mounted on 1in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T  $_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $_1$  ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80  $\,\mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T <sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

F. The Schottky appears in parallel with the MOSFET body diode, even though it is a separate chip. Therefore, we provide the net forward drop, capacitance and recovery characteristics of the MOSFET and Schottky. However, the thermal resistance is specified for each chip separately Rev5: August 2005.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

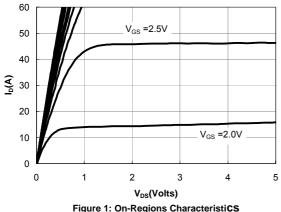


Figure 1: On-Regions CharacteristiCS

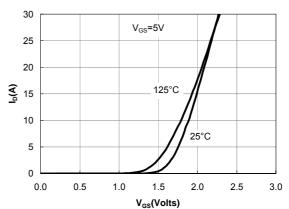


Figure 2: Transfer Characteristics

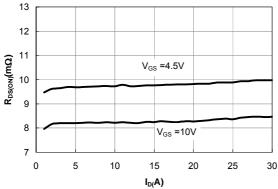


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

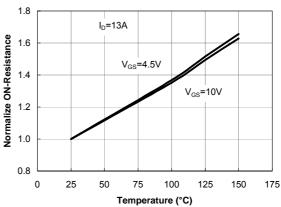


Figure 4: On-Resistance vs. Junction Temperature

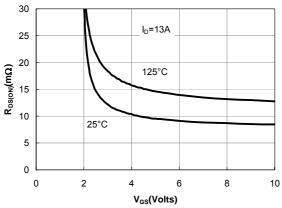


Figure 5: On-Resistance vs. Gate-Source Voltage

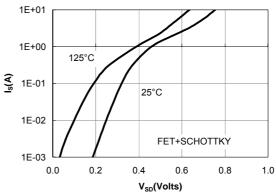
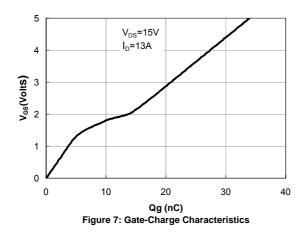


Figure 6: Body-Diode Characteristics (Note F)



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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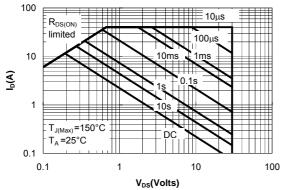
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Figure 8: Capacitance Characteristics



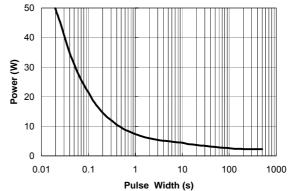


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

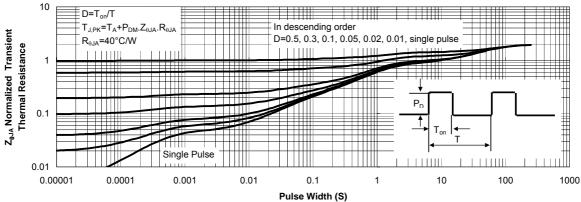
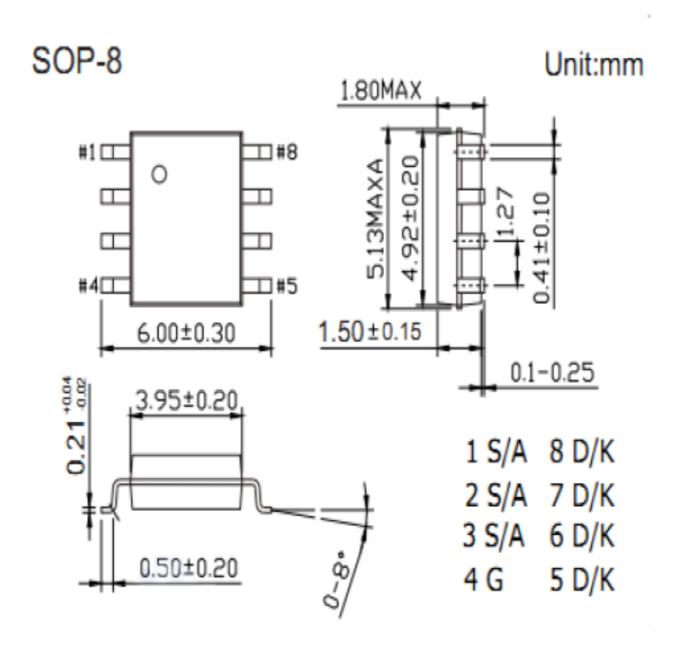


Figure 11: Normalized Maximum Transient Thermal Impedence



**SOIC (NARROW): 8-LEAD** 





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